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Ultra High Frequency Transistor Arrays

The HFA3046, HFA3096, HFA3127 and the HFA3128 are Ultra High Frequency Transistor Arrays that are fabricated from Intersil Corporation's complementary bipolar UHF-1 process. Each array consists of five dielectrically isolated transistors on a common monolithic substrate. The NPN transistors exhibit a f_T of 8GHz while the PNP transistors provide a f_T of 5.5GHz. Both types exhibit low noise (3.5dB), making them ideal for high frequency amplifier and mixer applications.

The HFA3046 and HFA3127 are all NPN arrays while the HFA3128 has all PNP transistors. The HFA3096 is an NPN-PNP combination. Access is provided to each of the terminals for the individual transistors for maximum application flexibility. Monolithic construction of these transistor arrays provides close electrical and thermal matching of the five transistors.

Intersil provides an Application Note illustrating the use of these devices as RF amplifiers. For more information, visit our website at www.intersil.com.

Features

- NPN Transistor (f_T) 8GHz
- NPN Current Gain (h_{FE})..... 130
- NPN Early Voltage (V_A) 50V
- PNP Transistor (f_T)..... 5.5GHz
- PNP Current Gain (h_{FE})..... 60
- PNP Early Voltage (V_A) 20V
- Noise Figure (50 Ω) at 1.0GHz 3.5dB
- Collector to Collector Leakage <1pA
- Complete Isolation Between Transistors
- Pin Compatible with Industry Standard 3XXX Series Arrays
- Pb-Free Plus Anneal Available (RoHS Compliant)

Applications

- VHF/UHF Amplifiers
- VHF/UHF Mixers
- IF Converters
- Synchronous Detectors

Ordering Information

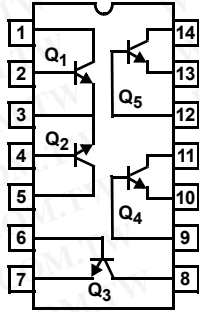
PART NUMBER*	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
HFA3046B	HFA3046B	-55 to 125	14 Ld SOIC	M14.15
HFA3046BZ (Note)	HFA3046BZ	-55 to 125	14 Ld SOIC (Pb-free)	M14.15
HFA3096B	HFA3096B	-55 to 125	16 Ld SOIC	M16.15
HFA3096BZ (Note)	HFA3096BZ	-55 to 125	16 Ld SOIC (Pb-free)	M16.15
HFA3127B	HFA3127B	-55 to 125	16 Ld SOIC	M16.15
HFA3127BZ (Note)	HFA3127BZ	-55 to 125	16 Ld SOIC (Pb-free)	M16.15
HFA3127R	127	-55 to 125	16 Ld 3x3 QFN	L16.3x3
HFA3127RZ (Note)	127Z	-55 to 125	16 Ld 3x3 QFN (Pb-free)	L16.3x3
HFA3128B	HFA3128B	-55 to 125	16 Ld SOIC	M16.15
HFA3128BZ (Note)	HFA3128BZ	-55 to 125	16 Ld SOIC (Pb-free)	M16.15
HFA3128R	128	-55 to 125	16 Ld 3x3 QFN	L16.3x3
HFA3128RZ (Note)	128Z	-55 to 125	16 Ld 3x3 QFN (Pb-free)	L16.3x3

*Add "96" suffix for tape and reel.

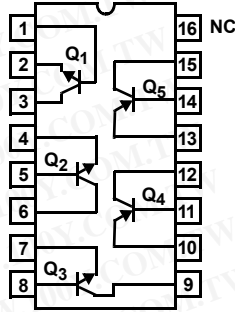
NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

Pinouts

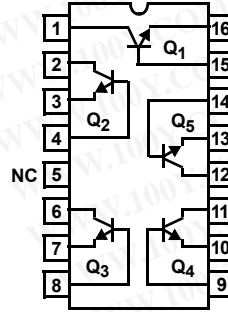
HFA3046
TOP VIEW



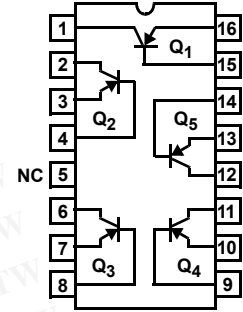
HFA3096
TOP VIEW



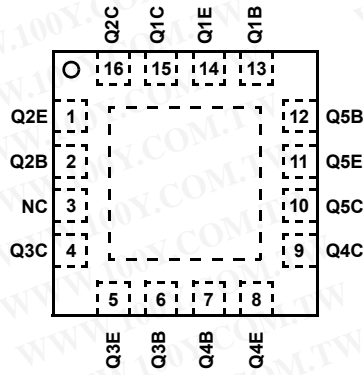
HFA3127
TOP VIEW



HFA3128
TOP VIEW



HFA3127, HFA3128
TOP VIEW



HFA3046, HFA3096, HFA3127, HFA3128

Absolute Maximum Ratings

Collector to Emitter Voltage (Open Base)	8V
Collector to Base Voltage (Open Emitter)	12V
Emitter to Base Voltage (Reverse Bias)	5.5V
Collector Current (100% Duty Cycle)	18.5mA at $T_J = 150^\circ\text{C}$
	34mA at $T_J = 125^\circ\text{C}$
	37mA at $T_J = 110^\circ\text{C}$
Peak Collector Current (Any Condition)	65mA

Operating Information

Temperature Range

Thermal Information

Thermal Resistance (Typical)	θ_{JA} ($^\circ\text{C}/\text{W}$)	θ_{JC} ($^\circ\text{C}/\text{W}$)
14 Ld SOIC Package (Note 1)	120	N/A
16 Ld SOIC Package (Note 1)	115	N/A
QFN Package (Notes 2, 3)	57	10
Maximum Power Dissipation (Any One Transistor)	0.15W	
Maximum Junction Temperature (Die)	175 $^\circ\text{C}$	
Maximum Junction Temperature (Plastic Package)	150 $^\circ\text{C}$	
Maximum Storage Temperature Range	-65 $^\circ\text{C}$ to 150 $^\circ\text{C}$	
Maximum Lead Temperature (Soldering 10s)	300 $^\circ\text{C}$ (SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

- θ_{JA} is measured with the component mounted on an evaluation PC board in free air.
- For θ_{JC} , the "case temp" location is the center of the exposed metal pad on the package underside.
- θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

Electrical Specifications $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	DIE			SOIC, QFN			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
DC NPN CHARACTERISTICS								
Collector to Base Breakdown Voltage, $V_{(BR)CBO}$	$I_C = 100\mu\text{A}$, $I_E = 0$	12	18	-	12	18	-	V
Collector to Emitter Breakdown Voltage, $V_{(BR)CEO}$	$I_C = 100\mu\text{A}$, $I_B = 0$	8	12	-	8	12	-	V
Collector to Emitter Breakdown Voltage, $V_{(BR)CES}$	$I_C = 100\mu\text{A}$, Base Shorted to Emitter	10	20	-	10	20	-	V
Emitter to Base Breakdown Voltage, $V_{(BR)EBO}$	$I_E = 10\mu\text{A}$, $I_C = 0$	5.5	6	-	5.5	6	-	V
Collector-Cutoff-Current, I_{CEO}	$V_{CE} = 6\text{V}$, $I_B = 0$	-	2	100	-	2	100	nA
Collector-Cutoff-Current, I_{CBO}	$V_{CB} = 8\text{V}$, $I_E = 0$	-	0.1	10	-	0.1	10	nA
Collector to Emitter Saturation Voltage, $V_{CE(SAT)}$	$I_C = 10\text{mA}$, $I_B = 1\text{mA}$	-	0.3	0.5	-	0.3	0.5	V
Base to Emitter Voltage, V_{BE}	$I_C = 10\text{mA}$	-	0.85	0.95	-	0.85	0.95	V
DC Forward-Current Transfer Ratio, h_{FE}	$I_C = 10\text{mA}$, $V_{CE} = 2\text{V}$	40	130	-	40	130	-	
Early Voltage, V_A	$I_C = 1\text{mA}$, $V_{CE} = 3.5\text{V}$	20	50	-	20	50	-	V
Base to Emitter Voltage Drift	$I_C = 10\text{mA}$	-	-1.5	-	-	-1.5	-	mV/ $^\circ\text{C}$
Collector to Collector Leakage		-	1	-	-	1	-	pA

Electrical Specifications $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	DIE			SOIC, QFN			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
DYNAMIC NPN CHARACTERISTICS								
Noise Figure	$f = 1.0\text{GHz}$, $V_{CE} = 5\text{V}$, $I_C = 5\text{mA}$, $Z_S = 50\Omega$	-	3.5	-	-	3.5	-	dB
f_T Current Gain-Bandwidth Product	$I_C = 1\text{mA}$, $V_{CE} = 5\text{V}$	-	5.5	-	-	5.5	-	GHz
	$I_C = 10\text{mA}$, $V_{CE} = 5\text{V}$	-	8	-	-	8	-	GHz

HFA3046, HFA3096, HFA3127, HFA3128

Electrical Specifications $T_A = 25^\circ\text{C}$ (Continued)

PARAMETER	TEST CONDITIONS	DIE			SOIC, QFN			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
Power Gain-Bandwidth Product, f_{MAX}	$I_C = 10\text{mA}$, $V_{\text{CE}} = 5\text{V}$	-	6	-	-	2.5	-	GHz
Base to Emitter Capacitance	$V_{\text{BE}} = -3\text{V}$	-	200	-	-	500	-	fF
Collector to Base Capacitance	$V_{\text{CB}} = 3\text{V}$	-	200	-	-	500	-	fF

Electrical Specifications $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	DIE			SOIC, QFN			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
DC PNP CHARACTERISTICS								
Collector to Base Breakdown Voltage, $V_{(\text{BR})\text{CBO}}$	$I_C = -100\mu\text{A}$, $I_E = 0$	10	15	-	10	15	-	V
Collector to Emitter Breakdown Voltage, $V_{(\text{BR})\text{CEO}}$	$I_C = -100\mu\text{A}$, $I_B = 0$	8	15	-	8	15	-	V
Collector to Emitter Breakdown Voltage, $V_{(\text{BR})\text{CES}}$	$I_C = -100\mu\text{A}$, Base Shorted to Emitter	10	15	-	10	15	-	V
Emitter to Base Breakdown Voltage, $V_{(\text{BR})\text{EBO}}$	$I_E = -10\mu\text{A}$, $I_C = 0$	4.5	5	-	4.5	5	-	V
Collector Cutoff Current, I_{CEO}	$V_{\text{CE}} = -6\text{V}$, $I_B = 0$	-	2	100	-	2	100	nA
Collector Cutoff Current, I_{CBO}	$V_{\text{CB}} = -8\text{V}$, $I_E = 0$	-	0.1	10	-	0.1	10	nA
Collector to Emitter Saturation Voltage, $V_{\text{CE}(\text{SAT})}$	$I_C = -10\text{mA}$, $I_B = -1\text{mA}$	-	0.3	0.5	-	0.3	0.5	V
Base to Emitter Voltage, V_{BE}	$I_C = -10\text{mA}$	-	0.85	0.95	-	0.85	0.95	V
DC Forward-Current Transfer Ratio, h_{FE}	$I_C = -10\text{mA}$, $V_{\text{CE}} = -2\text{V}$	20	60	-	20	60	-	
Early Voltage, V_A	$I_C = -1\text{mA}$, $V_{\text{CE}} = -3.5\text{V}$	10	20	-	10	20	-	V
Base to Emitter Voltage Drift	$I_C = -10\text{mA}$	-	-1.5	-	-	-1.5	-	$\text{mV}/^\circ\text{C}$
Collector to Collector Leakage		-	1	-	-	1	-	pA

Electrical Specifications $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	DIE			SOIC, QFN			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
DYNAMIC PNP CHARACTERISTICS								
Noise Figure	$f = 1.0\text{GHz}$, $V_{\text{CE}} = -5\text{V}$, $I_C = -5\text{mA}$, $Z_S = 50\Omega$	-	3.5	-	-	3.5	-	dB
f_T Current Gain-Bandwidth Product	$I_C = -1\text{mA}$, $V_{\text{CE}} = -5\text{V}$	-	2	-	-	2	-	GHz
	$I_C = -10\text{mA}$, $V_{\text{CE}} = -5\text{V}$	-	5.5	-	-	5.5	-	GHz
Power Gain-Bandwidth Product	$I_C = -10\text{mA}$, $V_{\text{CE}} = -5\text{V}$	-	3	-	-	2	-	GHz
Base to Emitter Capacitance	$V_{\text{BE}} = 3\text{V}$	-	200	-	-	500	-	fF
Collector to Base Capacitance	$V_{\text{CB}} = -3\text{V}$	-	300	-	-	600	-	fF

HFA3046, HFA3096, HFA3127, HFA3128

Electrical Specifications $T_A = 25^\circ\text{C}$ (Continued)

PARAMETER	TEST CONDITIONS	DIE			SOIC, QFN			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
DIFFERENTIAL PAIR MATCHING CHARACTERISTICS FOR THE HFA3046								
Input Offset Voltage	$I_C = 10\text{mA}$, $V_{CE} = 5\text{V}$	-	1.5	5.0	-	1.5	5.0	mV
Input Offset Current	$I_C = 10\text{mA}$, $V_{CE} = 5\text{V}$	-	5	25	-	5	25	μA
Input Offset Voltage TC	$I_C = 10\text{mA}$, $V_{CE} = 5\text{V}$	-	0.5	-	-	0.5	-	$\mu\text{V}/^\circ\text{C}$

S-Parameter and PSPICE model data is available from Intersil Sales Offices, and Intersil Corporation's web site.

Common Emitter S-Parameters of NPN $3\mu\text{m} \times 50\mu\text{m}$ Transistor

FREQ. (Hz)	$ S_{11} $	PHASE(S_{11})	$ S_{21} $	PHASE(S_{21})	$ S_{12} $	PHASE(S_{12})	$ S_{22} $	PHASE(S_{22})
$V_{CE} = 5\text{V}$ and $I_C = 5\text{mA}$								
1.0E+08	0.83	-11.78	11.07	168.57	1.41E-02	78.88	0.97	-11.05
2.0E+08	0.79	-22.82	10.51	157.89	2.69E-02	68.63	0.93	-21.35
3.0E+08	0.73	-32.64	9.75	148.44	3.75E-02	59.58	0.86	-30.44
4.0E+08	0.67	-41.08	8.91	140.36	4.57E-02	51.90	0.79	-38.16
5.0E+08	0.61	-48.23	8.10	133.56	5.19E-02	45.50	0.73	-44.59
6.0E+08	0.55	-54.27	7.35	127.88	5.65E-02	40.21	0.67	-49.93
7.0E+08	0.50	-59.41	6.69	123.10	6.00E-02	35.82	0.62	-54.37
8.0E+08	0.46	-63.81	6.11	119.04	6.27E-02	32.15	0.57	-58.10
9.0E+08	0.42	-67.63	5.61	115.57	6.47E-02	29.07	0.53	-61.25
1.0E+09	0.39	-70.98	5.17	112.55	6.63E-02	26.45	0.50	-63.96
1.1E+09	0.36	-73.95	4.79	109.91	6.75E-02	24.19	0.47	-66.31
1.2E+09	0.34	-76.62	4.45	107.57	6.85E-02	22.24	0.45	-68.37
1.3E+09	0.32	-79.04	4.15	105.47	6.93E-02	20.53	0.43	-70.19
1.4E+09	0.30	-81.25	3.89	103.57	7.00E-02	19.02	0.41	-71.83
1.5E+09	0.28	-83.28	3.66	101.84	7.05E-02	17.69	0.40	-73.31
1.6E+09	0.27	-85.17	3.45	100.26	7.10E-02	16.49	0.39	-74.66
1.7E+09	0.25	-86.92	3.27	98.79	7.13E-02	15.41	0.38	-75.90
1.8E+09	0.24	-88.57	3.10	97.43	7.17E-02	14.43	0.37	-77.05
1.9E+09	0.23	-90.12	2.94	96.15	7.19E-02	13.54	0.36	-78.12
2.0E+09	0.22	-91.59	2.80	94.95	7.21E-02	12.73	0.35	-79.13
2.1E+09	0.21	-92.98	2.68	93.81	7.23E-02	11.98	0.35	-80.09
2.2E+09	0.20	-94.30	2.56	92.73	7.25E-02	11.29	0.34	-80.99
2.3E+09	0.20	-95.57	2.45	91.70	7.27E-02	10.64	0.34	-81.85
2.4E+09	0.19	-96.78	2.35	90.72	7.28E-02	10.05	0.33	-82.68
2.5E+09	0.18	-97.93	2.26	89.78	7.29E-02	9.49	0.33	-83.47
2.6E+09	0.18	-99.05	2.18	88.87	7.30E-02	8.96	0.33	-84.23
2.7E+09	0.17	-100.12	2.10	88.00	7.31E-02	8.47	0.33	-84.97
2.8E+09	0.17	-101.15	2.02	87.15	7.31E-02	8.01	0.33	-85.68
2.9E+09	0.16	-102.15	1.96	86.33	7.32E-02	7.57	0.33	-86.37
3.0E+09	0.16	-103.11	1.89	85.54	7.32E-02	7.16	0.33	-87.05

Common Emitter S-Parameters of NPN 3 μ m x 50 μ m Transistor (Continued)

FREQ. (Hz)	S ₁₁	PHASE(S ₁₁)	S ₂₁	PHASE(S ₂₁)	S ₁₂	PHASE(S ₁₂)	S ₂₂	PHASE(S ₂₂)
V_{CE} = 5V and I_C = 10mA								
1.0E+08	0.72	-16.43	15.12	165.22	1.27E-02	75.41	0.95	-14.26
2.0E+08	0.67	-31.26	13.90	152.04	2.34E-02	62.89	0.88	-26.95
3.0E+08	0.60	-43.76	12.39	141.18	3.13E-02	52.58	0.79	-37.31
4.0E+08	0.53	-54.00	10.92	132.57	3.68E-02	44.50	0.70	-45.45
5.0E+08	0.47	-62.38	9.62	125.78	4.05E-02	38.23	0.63	-51.77
6.0E+08	0.42	-69.35	8.53	120.37	4.31E-02	33.34	0.57	-56.72
7.0E+08	0.37	-75.26	7.62	116.00	4.49E-02	29.47	0.51	-60.65
8.0E+08	0.34	-80.36	6.86	112.39	4.63E-02	26.37	0.47	-63.85
9.0E+08	0.31	-84.84	6.22	109.36	4.72E-02	23.84	0.44	-66.49
1.0E+09	0.29	-88.83	5.69	106.77	4.80E-02	21.75	0.41	-68.71
1.1E+09	0.27	-92.44	5.23	104.51	4.86E-02	20.00	0.39	-70.62
1.2E+09	0.25	-95.73	4.83	102.53	4.90E-02	18.52	0.37	-72.28
1.3E+09	0.24	-98.75	4.49	100.75	4.94E-02	17.25	0.35	-73.76
1.4E+09	0.22	-101.55	4.19	99.16	4.97E-02	16.15	0.34	-75.08
1.5E+09	0.21	-104.15	3.93	97.70	4.99E-02	15.19	0.33	-76.28
1.6E+09	0.20	-106.57	3.70	96.36	5.01E-02	14.34	0.32	-77.38
1.7E+09	0.20	-108.85	3.49	95.12	5.03E-02	13.60	0.31	-78.41
1.8E+09	0.19	-110.98	3.30	93.96	5.05E-02	12.94	0.31	-79.37
1.9E+09	0.18	-113.00	3.13	92.87	5.06E-02	12.34	0.30	-80.27
2.0E+09	0.18	-114.90	2.98	91.85	5.07E-02	11.81	0.30	-81.13
2.1E+09	0.17	-116.69	2.84	90.87	5.08E-02	11.33	0.30	-81.95
2.2E+09	0.17	-118.39	2.72	89.94	5.09E-02	10.89	0.29	-82.74
2.3E+09	0.16	-120.01	2.60	89.06	5.10E-02	10.50	0.29	-83.50
2.4E+09	0.16	-121.54	2.49	88.21	5.11E-02	10.13	0.29	-84.24
2.5E+09	0.16	-122.99	2.39	87.39	5.12E-02	9.80	0.29	-84.95
2.6E+09	0.15	-124.37	2.30	86.60	5.12E-02	9.49	0.29	-85.64
2.7E+09	0.15	-125.69	2.22	85.83	5.13E-02	9.21	0.29	-86.32
2.8E+09	0.15	-126.94	2.14	85.09	5.13E-02	8.95	0.29	-86.98
2.9E+09	0.15	-128.14	2.06	84.36	5.14E-02	8.71	0.29	-87.62
3.0E+09	0.14	-129.27	1.99	83.66	5.15E-02	8.49	0.29	-88.25

Common Emitter S-Parameters of PNP 3 μ m x 50 μ m Transistor

FREQ. (Hz)	S ₁₁	PHASE(S ₁₁)	S ₂₁	PHASE(S ₂₁)	S ₁₂	PHASE(S ₁₂)	S ₂₂	PHASE(S ₂₂)
V_{CE} = -5V and I_C = -5mA								
1.0E+08	0.72	-16.65	10.11	166.77	1.66E-02	77.18	0.96	-10.76
2.0E+08	0.68	-32.12	9.44	154.69	3.10E-02	65.94	0.90	-20.38
3.0E+08	0.62	-45.73	8.57	144.40	4.23E-02	56.39	0.82	-28.25
4.0E+08	0.57	-57.39	7.68	135.95	5.05E-02	48.66	0.74	-34.31
5.0E+08	0.52	-67.32	6.86	129.11	5.64E-02	42.52	0.67	-38.81

HFA3046, HFA3096, HFA3127, HFA3128

Common Emitter S-Parameters of PNP 3 μ m x 50 μ m Transistor (Continued)

FREQ. (Hz)	S ₁₁	PHASE(S ₁₁)	S ₂₁	PHASE(S ₂₁)	S ₁₂	PHASE(S ₁₂)	S ₂₂	PHASE(S ₂₂)
6.0E+08	0.47	-75.83	6.14	123.55	6.07E-02	37.66	0.61	-42.10
7.0E+08	0.43	-83.18	5.53	118.98	6.37E-02	33.79	0.55	-44.47
8.0E+08	0.40	-89.60	5.01	115.17	6.60E-02	30.67	0.51	-46.15
9.0E+08	0.38	-95.26	4.56	111.94	6.77E-02	28.14	0.47	-47.33
1.0E+09	0.36	-100.29	4.18	109.17	6.91E-02	26.06	0.44	-48.15
1.1E+09	0.34	-104.80	3.86	106.76	7.01E-02	24.33	0.41	-48.69
1.2E+09	0.33	-108.86	3.58	104.63	7.09E-02	22.89	0.39	-49.05
1.3E+09	0.32	-112.53	3.33	102.72	7.16E-02	21.67	0.37	-49.26
1.4E+09	0.30	-115.86	3.12	101.01	7.22E-02	20.64	0.36	-49.38
1.5E+09	0.30	-118.90	2.92	99.44	7.27E-02	19.76	0.34	-49.43
1.6E+09	0.29	-121.69	2.75	98.01	7.32E-02	19.00	0.33	-49.44
1.7E+09	0.28	-124.24	2.60	96.68	7.35E-02	18.35	0.32	-49.43
1.8E+09	0.28	-126.59	2.47	95.44	7.39E-02	17.79	0.31	-49.40
1.9E+09	0.27	-128.76	2.34	94.29	7.42E-02	17.30	0.30	-49.38
2.0E+09	0.27	-130.77	2.23	93.19	7.45E-02	16.88	0.30	-49.36
2.1E+09	0.26	-132.63	2.13	92.16	7.47E-02	16.52	0.29	-49.35
2.2E+09	0.26	-134.35	2.04	91.18	7.50E-02	16.20	0.28	-49.35
2.3E+09	0.26	-135.96	1.95	90.24	7.52E-02	15.92	0.28	-49.38
2.4E+09	0.25	-137.46	1.87	89.34	7.55E-02	15.68	0.28	-49.42
2.5E+09	0.25	-138.86	1.80	88.48	7.57E-02	15.48	0.27	-49.49
2.6E+09	0.25	-140.17	1.73	87.65	7.59E-02	15.30	0.27	-49.56
2.7E+09	0.25	-141.39	1.67	86.85	7.61E-02	15.15	0.26	-49.67
2.8E+09	0.25	-142.54	1.61	86.07	7.63E-02	15.01	0.26	-49.81
2.9E+09	0.24	-143.62	1.56	85.31	7.65E-02	14.90	0.26	-49.96
3.0E+09	0.24	-144.64	1.51	84.58	7.67E-02	14.81	0.26	-50.13
V_{CE} = -5V, I_C = -10mA								
1.0E+08	0.58	-23.24	13.03	163.45	1.43E-02	73.38	0.93	-13.46
2.0E+08	0.53	-44.07	11.75	149.11	2.58E-02	60.43	0.85	-24.76
3.0E+08	0.48	-61.50	10.25	137.78	3.38E-02	50.16	0.74	-33.10
4.0E+08	0.43	-75.73	8.88	129.12	3.90E-02	42.49	0.65	-38.83
5.0E+08	0.40	-87.36	7.72	122.49	4.25E-02	36.81	0.58	-42.63
6.0E+08	0.37	-96.94	6.78	117.33	4.48E-02	32.59	0.51	-45.07
7.0E+08	0.35	-104.92	6.01	113.22	4.64E-02	29.39	0.47	-46.60
8.0E+08	0.33	-111.64	5.39	109.85	4.76E-02	26.94	0.43	-47.49
9.0E+08	0.32	-117.36	4.87	107.05	4.85E-02	25.04	0.40	-47.97
1.0E+09	0.31	-122.27	4.44	104.66	4.92E-02	23.55	0.37	-48.18
1.1E+09	0.30	-126.51	4.07	102.59	4.97E-02	22.37	0.35	-48.20
1.2E+09	0.30	-130.21	3.76	100.76	5.02E-02	21.44	0.33	-48.11

Common Emitter S-Parameters of PNP 3 μ m x 50 μ m Transistor (Continued)

FREQ. (Hz)	S ₁₁	PHASE(S ₁₁)	S ₂₁	PHASE(S ₂₁)	S ₁₂	PHASE(S ₁₂)	S ₂₂	PHASE(S ₂₂)
1.3E+09	0.29	-133.46	3.49	99.14	5.06E-02	20.70	0.32	-47.95
1.4E+09	0.29	-136.33	3.25	97.67	5.09E-02	20.11	0.31	-47.77
1.5E+09	0.28	-138.89	3.05	96.33	5.12E-02	19.65	0.30	-47.58
1.6E+09	0.28	-141.17	2.87	95.10	5.15E-02	19.29	0.29	-47.39
1.7E+09	0.28	-143.21	2.70	93.96	5.18E-02	19.01	0.28	-47.23
1.8E+09	0.28	-145.06	2.56	92.90	5.21E-02	18.80	0.27	-47.09
1.9E+09	0.27	-146.73	2.43	91.90	5.23E-02	18.65	0.27	-46.98
2.0E+09	0.27	-148.26	2.31	90.95	5.26E-02	18.55	0.26	-46.91
2.1E+09	0.27	-149.65	2.20	90.05	5.28E-02	18.49	0.26	-46.87
2.2E+09	0.27	-150.92	2.10	89.20	5.30E-02	18.46	0.25	-46.87
2.3E+09	0.27	-152.10	2.01	88.37	5.33E-02	18.47	0.25	-46.90
2.4E+09	0.27	-153.18	1.93	87.59	5.35E-02	18.50	0.25	-46.97
2.5E+09	0.27	-154.17	1.86	86.82	5.38E-02	18.55	0.24	-47.07
2.6E+09	0.26	-155.10	1.79	86.09	5.40E-02	18.62	0.24	-47.18
2.7E+09	0.26	-155.96	1.72	85.38	5.42E-02	18.71	0.24	-47.34
2.8E+09	0.26	-156.76	1.66	84.68	5.45E-02	18.80	0.24	-47.55
2.9E+09	0.26	-157.51	1.60	84.01	5.47E-02	18.91	0.24	-47.76
3.0E+09	0.26	-158.21	1.55	83.35	5.50E-02	19.03	0.23	-48.00

Typical Performance Curves

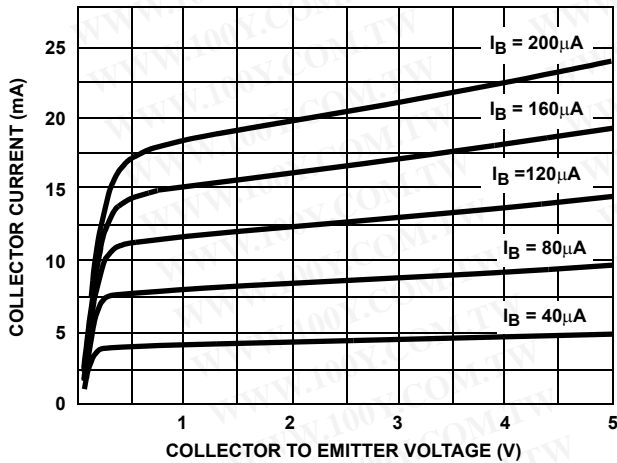


FIGURE 1. NPN COLLECTOR CURRENT vs COLLECTOR TO EMITTER VOLTAGE

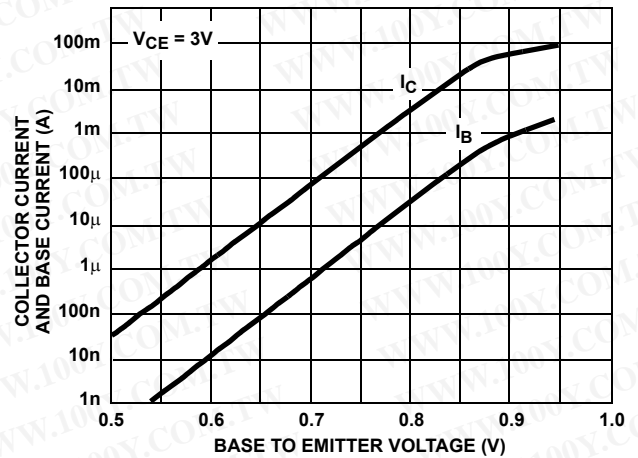


FIGURE 2. NPN COLLECTOR CURRENT AND BASE CURRENT vs BASE TO EMITTER VOLTAGE

Typical Performance Curves (Continued)

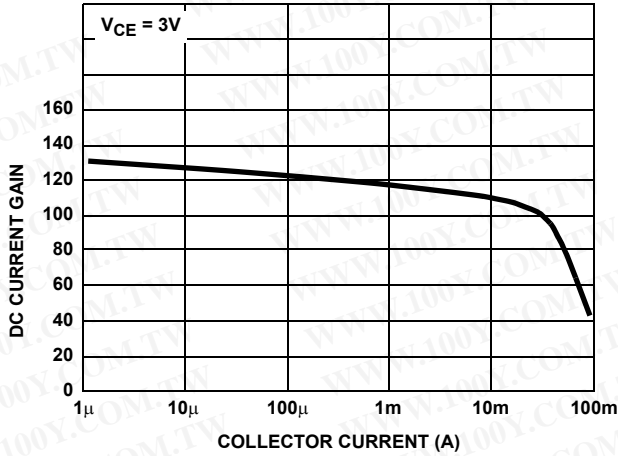


FIGURE 3. NPN DC CURRENT GAIN vs COLLECTOR CURRENT

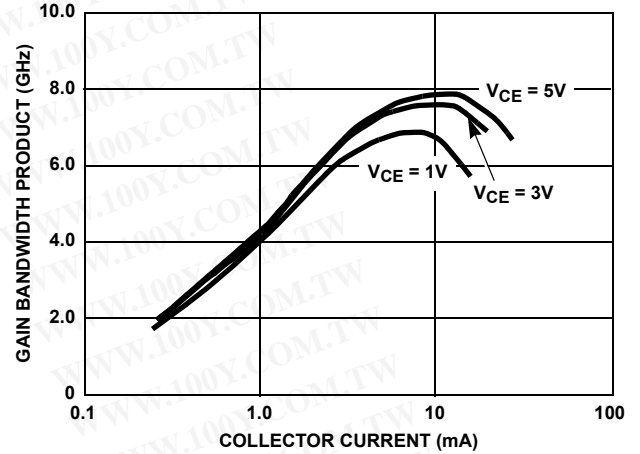


FIGURE 4. NPN GAIN BANDWIDTH PRODUCT vs COLLECTOR CURRENT (UHF 3 x 50 WITH BOND PADS)

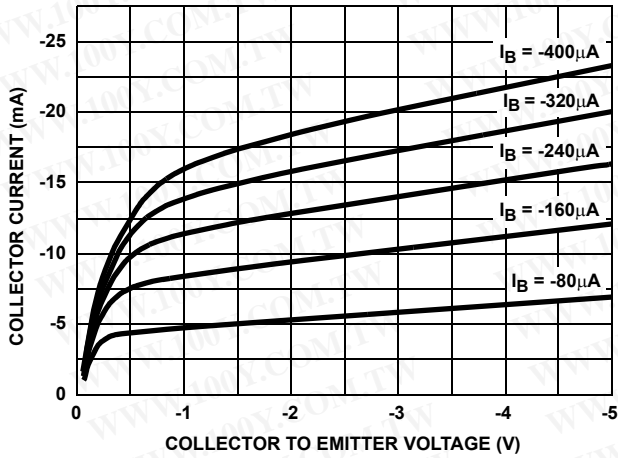


FIGURE 5. PNP COLLECTOR CURRENT vs COLLECTOR TO EMITTER VOLTAGE

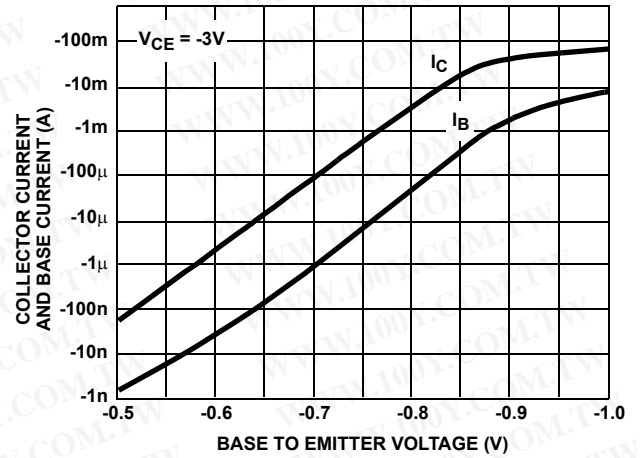


FIGURE 6. PNP COLLECTOR CURRENT AND BASE CURRENT vs BASE TO EMITTER VOLTAGE

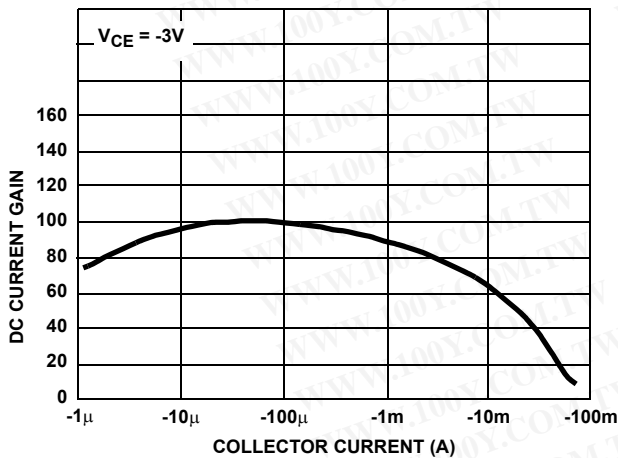


FIGURE 7. PNP DC CURRENT GAIN vs COLLECTOR CURRENT

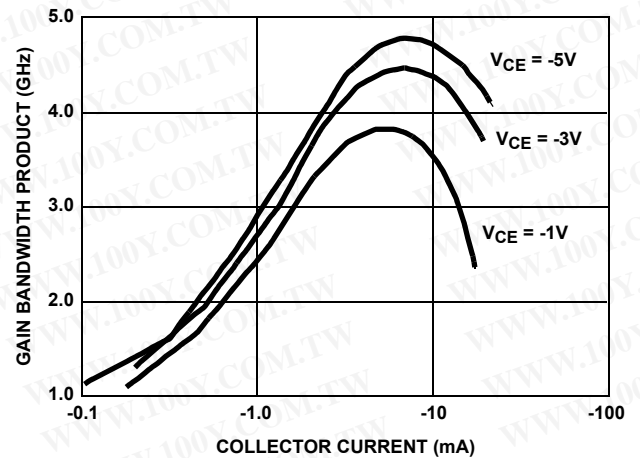


FIGURE 8. PNP GAIN BANDWIDTH PRODUCT vs COLLECTOR CURRENT (UHF 3 x 50 WITH BOND PADS)

Die Characteristics

DIE DIMENSIONS:

53 mils x 52 mils x 19 mils
 1340µm x 1320µm x 483µm

METALLIZATION:

Type: Metal 1: AlCu(2%)/TiW
 Thickness: Metal 1: 8kÅ ±0.4kÅ
 Type: Metal 2: AlCu(2%)
 Thickness: Metal 2: 16kÅ ±0.8kÅ

PASSIVATION:

Type: Nitride
 Thickness: 4kÅ ±0.5kÅ

PROCESS:

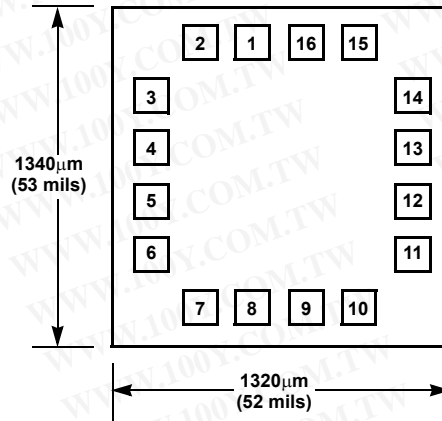
UHF-1

SUBSTRATE POTENTIAL: (POWERED UP)

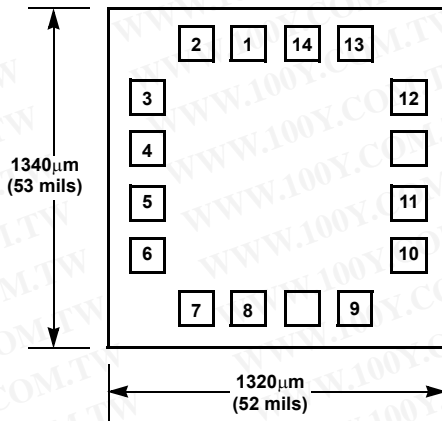
Unbiased

Metallization Mask Layout

HFA3096, HFA3127, HFA3128

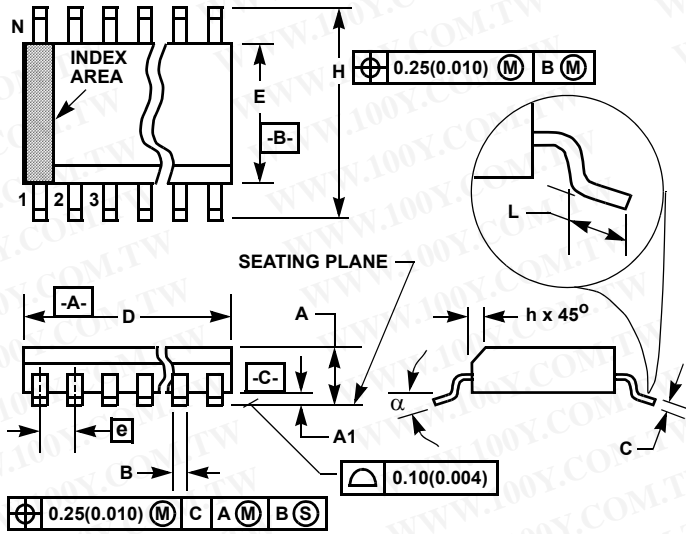


HFA3046



Pad numbers correspond to SOIC pinout.

Small Outline Plastic Packages (SOIC)



M14.15 (JEDEC MS-012-AB ISSUE C)
14 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

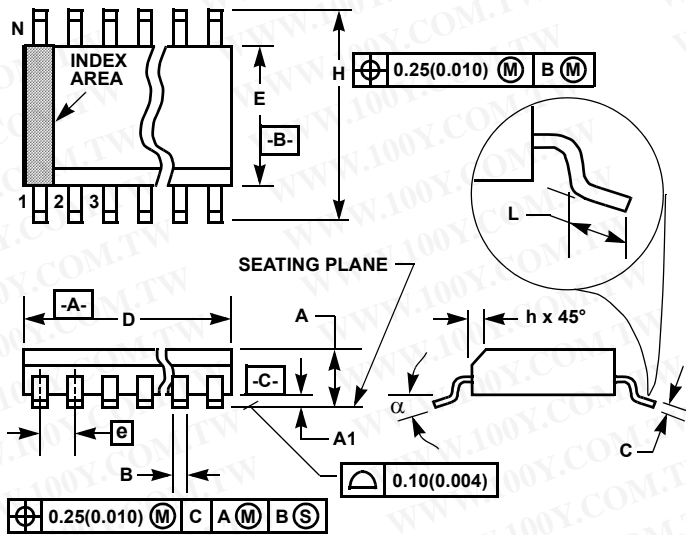
SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
B	0.013	0.020	0.33	0.51	9
C	0.0075	0.0098	0.19	0.25	-
D	0.3367	0.3444	8.55	8.75	3
E	0.1497	0.1574	3.80	4.00	4
e	0.050 BSC		1.27 BSC		-
H	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
N	14		14		7
alpha	0°	8°	0°	8°	-

NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

Rev. 0 12/93

Small Outline Plastic Packages (SOIC)



M16.15 (JEDEC MS-012-AC ISSUE C)
16 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
B	0.013	0.020	0.33	0.51	9
C	0.0075	0.0098	0.19	0.25	-
D	0.3859	0.3937	9.80	10.00	3
E	0.1497	0.1574	3.80	4.00	4
e	0.050 BSC		1.27 BSC		-
H	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
N	16		16		7
α	0°	8°	0°	8°	-

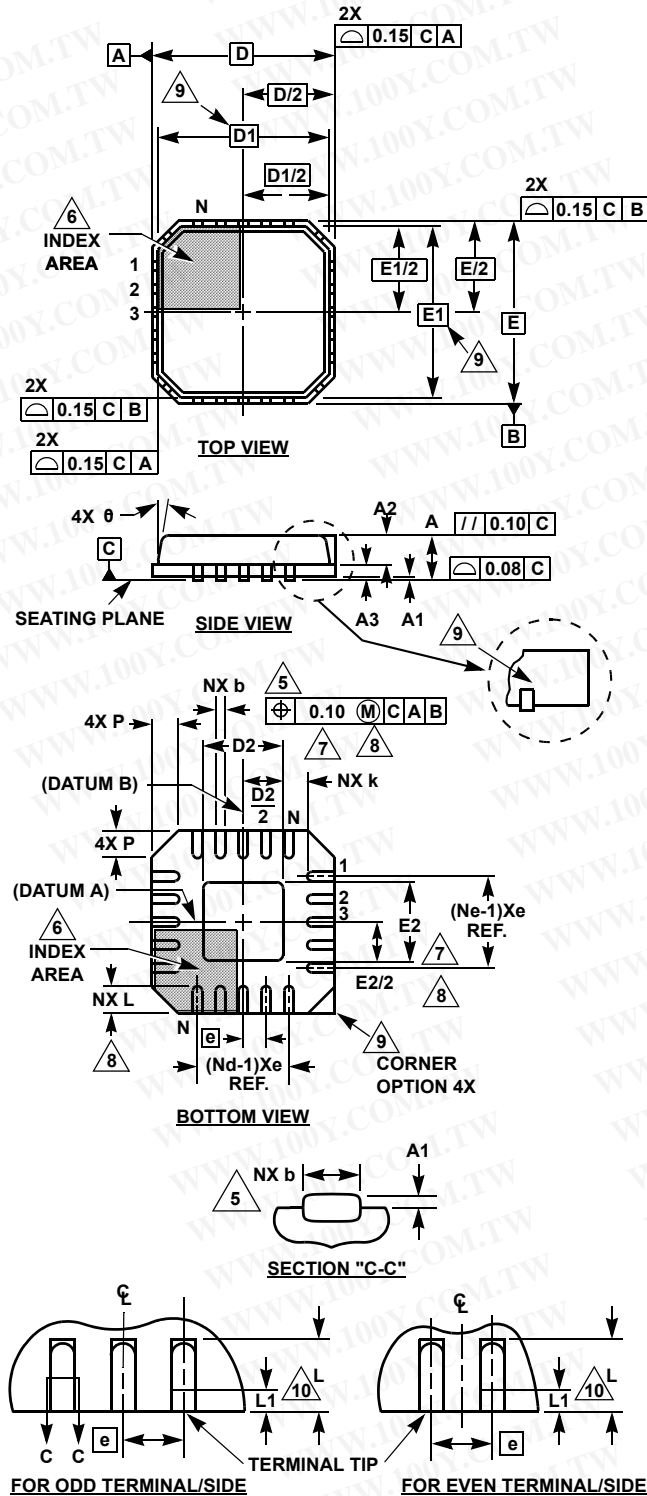
NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

Rev. 1 6/05

Quad Flat No-Lead Plastic Package (QFN)
Micro Lead Frame Plastic Package (MLFP)

L16.3x3
16 LEAD QUAD FLAT NO-LEAD PLASTIC PACKAGE



SYMBOL	MILLIMETERS			NOTES
	MIN	NOMINAL	MAX	
A	0.80	0.90	1.00	-
A1	-	-	0.05	-
A2	-	-	1.00	9
A3	0.20 REF			9
b	0.18	0.23	0.30	5, 8
D	3.00 BSC			-
D1	2.75 BSC			9
D2	1.35	1.50	1.65	7, 8, 10
E	3.00 BSC			-
E1	2.75 BSC			9
E2	1.35	1.50	1.65	7, 8, 10
e	0.50 BSC			-
k	0.20	-	-	-
L	0.30	0.40	0.50	8
N	16			2
Nd	4			3
Ne	4			3
P	-	-	0.60	9
θ	-	-	12	9

Rev. 1 6/04

NOTES:

1. Dimensioning and tolerancing conform to ASME Y14.5-1994.
2. N is the number of terminals.
3. Nd and Ne refer to the number of terminals on each D and E.
4. All dimensions are in millimeters. Angles are in degrees.
5. Dimension b applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
6. The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.
7. Dimensions D2 and E2 are for the exposed pads which provide improved electrical and thermal performance.
8. Nominal dimensions are provided to assist with PCB Land Pattern Design efforts, see Intersil Technical Brief TB389.
9. Features and dimensions A2, A3, D1, E1, P & θ are present when Anvil singulation method is used and not present for saw singulation.
10. Compliant to JEDEC MO-220VEED-2 Issue C, except for the E2 and D2 MAX dimension.

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 Intersil Corporation's quality certifications can be viewed at www.intersil.com/design/quality

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